

1200 VOLT, 30 AMP MOSFET FULL-BRIDGE MODULE

Features

- Isolated base plate
- Light weight low profile standard package
- Aluminum Nitride substrate
- High temperature engineering plastic shell construction



ELECTRICAL CHARACTERISTICS PER MOSFET LEG

(T_j=25°C UNLESS OTHERWISE SPECIFIED)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
MOSFET SPECIFICATIONS					
BV _{DSS}	Drain to Source Breakdown Voltage I _D = 100 μA, V _{GS} = 0V	1200	-	-	V
I _D	Continuous Drain Current T _C = 25°C T _C = 100°C	-	-	40 34	A
I _{D(pulse)}	Pulsed Drain Current, 1ms	-	-	90	A
V _{GS}	Gate to Source Voltage	-	-	-10/+25	V
I _{GSS}	Gate-Source Leakage Current, V _{GS} = -10/+22V	-	-	100	nA
V _{GS(th)}	Gate Threshold Voltage, I _D = 1mA, V _{DS} = V _{GS}	T _J = 25°C 1.8 T _J = 150°C 1.2	3.5 2.5	4.0 3.0	V
I _{DSS}	Zero Gate Voltage Drain Current V _{DS} = 1200 V, V _{GS} = 0V	-	-	100	μA
R _{DS(on)}	Drain-Source On-State Resistance I _D = 20A, V _{GS} = 20V	T _J = 25°C - T _J = 150°C -	80 90	100 113	mΩ
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Cap. V _{DS} = 400 V, V _{GS} = 0 V, f = 1 MHz, V _{AC} = 25 mV	- - -	1700 130 25	- - -	pF
t _{D(on)} t _R t _{D(off)} t _F	Turn On Delay Time Rise Time Turn Off Delay Time Fall Time V _{DS} = 800 V, I _D = 20A, V _{GS} = 20V, R _G = 0Ω, R _L = 40Ω	- - - -	19 28 45 20	- - - -	ns
E _{ON} E _{OFF}	Turn on Energy Loss Turn off Energy Loss V _{DS} = 800 V, I _D = 20A, V _{GS} = -2/+20V, R _G = 6.8Ω	- -	500 350	- -	μJ
R _{G(int)}	Internal Gate Resistance f = 1MHz, V _{AC} = 25mV	-	5	-	Ω
Q _{GS} Q _{GD} Q _G	Gate to Source Charge Gate to Drain Charge Total Gate Charge V _{DS} = 800 V, I _D = 20A, V _{GS} = 0/+20V	-	16 40 105	-	nC

REVERSE DIODE CHARACTERISTICS

(T_J=25°C UNLESS OTHERWISE SPECIFIED)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
DIODE SPECIFICATIONS					
V _{SD}	Diode Forward Voltage V _{GS} = 0V, I _{SD} = 10A	T _J = 25°C T _J = 150°C	- 3.3	3.5 3.8	V
I _S	Continuous Forward Current,	T _J = 25°C	-	20	A
t _{rr}	Reverse Recovery Time V _{GS} = 0V, I _{SD} = 20A, V _R = 800V, di/dt = 100A/μs	-	140	-	ns
Q _{rr}	Reverse Recovery Charge V _{GS} = 0V, I _{SD} = 20A, V _R = 800V, di/dt = 100A/μs	-	140	-	nC
I _{rrm}	Peak Reverse Recovery Current V _{GS} = 0V, I _{SD} = 20A, V _R = 800V, di/dt = 100A/μs	-	2	-	A

ZVS SiC DIODE CHARACTERISTICS

(T_J=25°C UNLESS OTHERWISE SPECIFIED)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
DIODE SPECIFICATIONS					
V _{R RM}	Repetitive Peak Reverse Voltage	1200	-	-	V
V _{R SM}	Surge Peak Reverse Voltage	1300	-	-	V
V _R	DC Peak Blocking Voltage	1200	-	-	V
I _F	Continuous Forward Current, T _J = 150°C	-	-	20	A
I _{F RM}	Repetitive Peak Forward Surge Current t _p = 10ms, Half Sine Pulse T _C = 25°C T _C = 110°C	-	-	91 61	A
I _{F SM}	Non-Repetitive Forward Surge Current t _p = 10ms, Half Sine Pulse T _C = 25°C T _C = 110°C	-	-	130 110	A
V _F	Forward Voltage I _F = 20A T _J = 25°C T _J = 150°C	-	1.5 2.2	1.8 3.0	V
I _R	Reverse Current V _R = 1200V T _J = 25°C T _J = 150°C	-	35 65	200 400	μA
Q _C	Total Capacitive Charge V _R = 800V, I _F = 20A, di/dt = 200A/μs, T _J = 25 °C	-	99	-	nC
C	Total Capacitance V _R = 0V, T _J = 25 °C, f = 1MHz V _R = 400V, T _J = 25 °C, f = 1MHz V _R = 800V, T _J = 25 °C, f = 1MHz	-	1500 93 67	-	pF

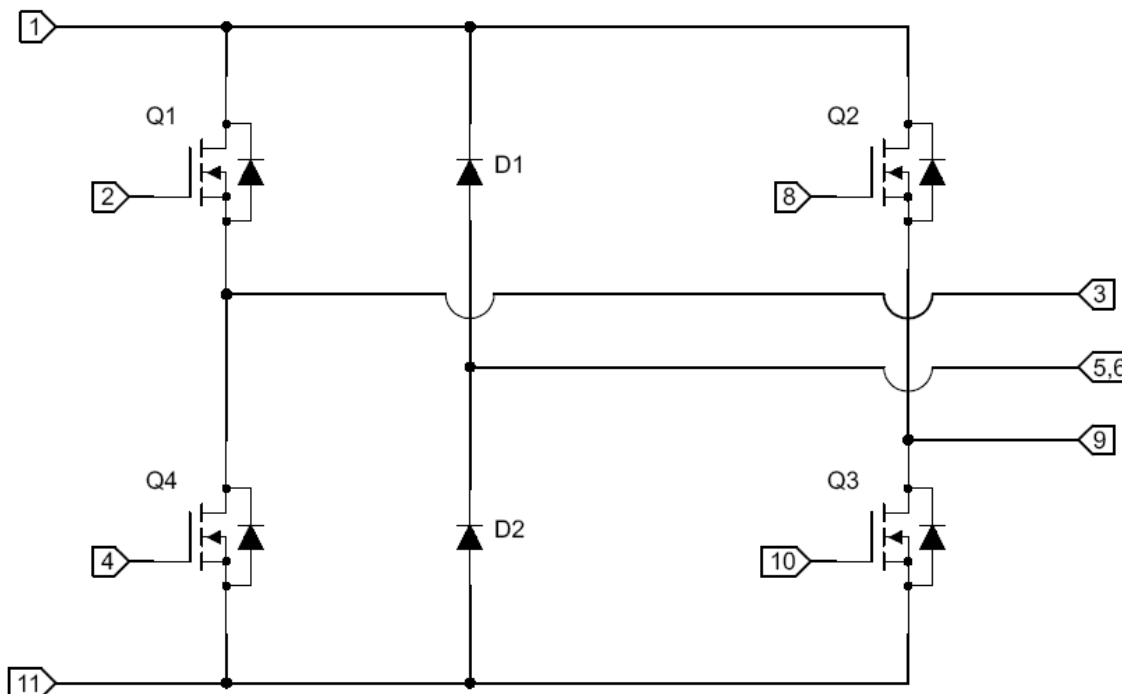
Note: Production units are only tested at room temperature. Low/High temperature operation is guaranteed by design.

THERMAL AND MECHANICAL CHARACTERISTICS

SYMBOL	PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta_{JB_M}}$	MOSFET Junction-to-Base Plate Thermal Resistance Per Leg	-	0.36	0.44	°C/W
$R_{\theta_{JB_D}}$	Diode Junction-to-Base Plate Thermal Resistance Per Leg	-	0.66	0.79	°C/W
V_{iso}	Isolation to Base Plate	-	-	2500	VDC
T_J	Operating Junction Temperature	-55	-	150	°C
T_{STG}	Storage Temperature	-55	-	150	°C
	Mounting Torque for Module Mounting	3	-	4	in-lbs.
	Weight	-	10	-	g

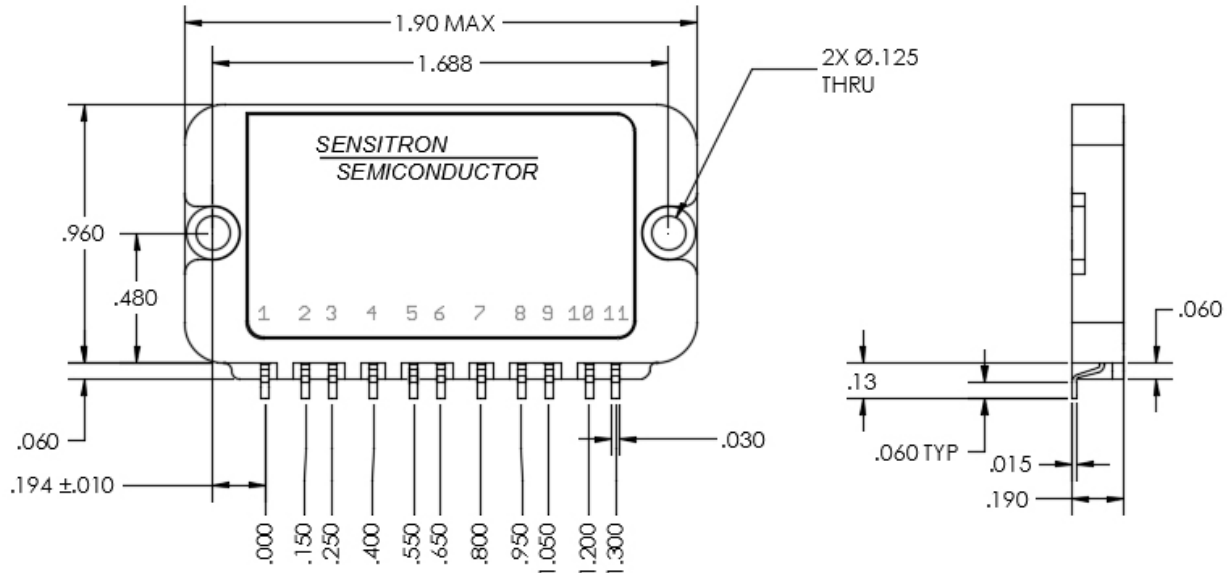
Recommended TIM = Laird Tgon 805

Schematic Diagram:



Note: Pin 7 is not used (No Connect)

Mechanical Outline (inches):



TOLERANCE UNLESS OTHERWISE NOTED:
 .XX = ±.010
 .XXX = ±.005

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